## **Listing of Claims**

This listing of claims will replace all prior versions and listings of claims in the application. Please amend the claims as follows:

- 1. (currently amended) A multilayer article comprising,
- a metal substrate,
- a first layer comprising an inner and outer surface,
- said first layer comprising a glass composition,

said glass composition comprising,

- 44.2 to 67.7 wt % SiO<sub>2</sub>, 10.1 to 23.4 wt % CaO, 5.7 to 13.3 wt % MgO, 10.3 to
- 23.6 wt % Na<sub>2</sub>O, 2.2 to 6.5 wt % K<sub>2</sub>O and 6.0 wt % P<sub>2</sub>O<sub>5</sub>.

wherein said glass composition optionally contains hydroxyapatite particles in an amount of up to 50 wt%.

- 2. cancelled
- 3. (original) The multilayer article of claim 1, wherein there is a first intermediate layer having an inner and outer surface, and said first intermediate layer is located between the substrate and first layer, said first intermediate layer comprising a glass composition as defined in claim 1.
- 4. cancelled
- 5. (previously presented) The multilayer article of claim 3,

wherein there is a second intermediate layer located between the first intermediate layer and the substrate,

said first layer, first intermediate layer and said second intermediate layer all comprising a glass composition as defined in claim 1,

wherein the hydroxyapatite concentration is highest in the first layer, lowest in the second intermediate layer, and present in the first intermediate layer in an amount that is in between the first layer and the second intermediate layer.

- 6. cancelled
- 7. cancelled
- 8. (previously presented) The multilayer article of claim 1, wherein the substrate is Ti or Ti6Al4V.
- 9. (previously presented) The multilayer article of claim 3, wherein the glass composition in the first layer comprises about 54.5 wt % SiO<sub>2</sub>, about 15 wt % CaO, about 8.5 wt % MgO, about 12.0 wt % Na<sub>2</sub>O, about 4.0 wt % K<sub>2</sub>O and about 6.0 wt % P<sub>2</sub>O<sub>5</sub>, and the glass composition in the first intermediate layer comprises

about 61.1 wt % SiO<sub>2</sub>, about 12.6 wt % CaO, about 7.2 wt % MgO, about 10.3 wt % Na<sub>2</sub>O, about 2.8 wt %  $K_2O$  and about 6.0 wt %  $P_2O_5$ ,

and the substrate is Ti or Ti6Al4V.

10. (previously presented) The multilayer article of claim 3, wherein the glass composition in the first layer comprises about 52.7 wt% SiO<sub>2</sub>, about 12.6 wt % CaO, about 7.1 wt % MgO, about 17.0 wt % Na<sub>2</sub>O, about 4.6 wt % K<sub>2</sub>O and about 6.0 wt % P<sub>2</sub>O<sub>5</sub>.

and the glass composition in the first intermediate layer comprises:

about 56.5 wt %  $SiO_2$ , about 15 wt % CaO, about 8.5 wt % MgO, about 11.0 wt %  $Na_2O$ , about 3.0 wt %  $K_2O$  and about 6.0 wt %  $P_2O_5$ , and the substrate is Ti or Ti6Al4V.

- 11. (previously presented) The multilayer article of claim 3, wherein the glass composition in the first layer and the first intermediate layer comprise about 56.5 wt % SiO<sub>2</sub>, about 15 wt % CaO, about 8.5 wt % MgO, about 11.0 wt % Na<sub>2</sub>O, about 3.0 wt % K<sub>2</sub>O and about 6.0 wt % P<sub>2</sub>O<sub>5</sub> and the hydroxyapatite amount in the first layer is 50 wt%, and the substrate is Ti or Ti6Al4V.
- 12. (previously presented) The multilayer article of claim 5, wherein the glass composition in the first layer, the first intermediate layer and the second intermediate layer each comprise about 61.1 wt % SiO<sub>2</sub>, about 12.6 wt % CaO, about 7.2 wt % MgO, about 10.3 wt % Na<sub>2</sub>O, about 2.8 wt % K<sub>2</sub>O and about 6.0 wt % P<sub>2</sub>O<sub>5</sub> and the hydroxyapatite amount in the first layer comprises 50 wt % and the substrate is Ti or Ti6Al4V.
- 13. cancelled
  - 14. cancelled
  - 15. cancelled
  - 16. cancelled
  - 17. cancelled
  - 18. cancelled
  - 19. cancelled
- 20. (currently amended) A multilayer article comprising, a metal substrate comprising Ti or Ti6Al4V,

n intermediate layers, where n is an integer,

a first layer comprising an inner and outer surface,

said n intermediate layers disposed between the metal substrate and the first layer, wherein the n intermediate layers and the first layer each independently comprise a glass/hydroxyapatite admixture comprising a glass composition and optionally hydroxyapatite particles (HA),

said glass composition comprising,

about 44.2 to about 67.7 wt %  $SiO_2$ , about 10.1 to about 23.4 wt % CaO, about 5.7 to about 13.3 wt % MgO, about 10.3 to about 23.6 wt %  $Na_2O$ , about 2.2 to about 6.5 wt %  $K_2O$  and about 6.0 wt %  $P_2O_5$ ,

and wherein said hydroxyapatite particles being optionally present in the glass/hydroxyapatite admixture in an amount of up to 50 wt%.

- 21. (previously presented) The multilayer article of claim 20, wherein the first layer has a glass composition which has a SiO<sub>2</sub> content between about 53 to about 57 wt %.
- 22. (previously presented) The multilayer article of claim 21, wherein: n=2.
- 23. (previously presented) The multilayer article of claim 1, wherein:

  the first layer has a glass composition which has a SiO<sub>2</sub>\_content between about 53 to about 57 wt %.
- 24. (previously presented) The multilayer article of claim 23, wherein: n=2.

- 25. (currently amended) The multilayer article of claim 20, wherein:
  the first layer has a glass composition which has a SiO<sub>2</sub> content between about 56 to about 68 67.7 wt %.
- 26. (previously presented) The multilayer article of claim 25, wherein: n=2.
- 27. (currently amended) The multilayer article of claim 1, wherein:

  the first layer has a glass composition which has a SiO<sub>2</sub> content between about 56 to about 68 67.7 wt %.
- 28. (previously presented) The multilayer article of claim 27, wherein: n=2.
- 29. (cancelled)

layer and the substrate,

30. (previously presented) The multilayer article of claim 3, wherein there is a second intermediate layer located between the first intermediate

said first layer, first intermediate layer and said second intermediate layer all comprising a glass composition as defined in claim 1,

wherein the SiO<sub>2</sub> concentration is lowest in the first layer, highest in the second intermediate layer, and present in the first intermediate layer in an amount that is in between the first layer and the second intermediate layer.